

DESCRIPTION

The MP5003 is a protection device designed to protect circuitry on the output (V_{OUT}) from transients on the input (V_{IN}). It also protects V_{IN} from undesired shorts and transients coming from the load.

At start up, inrush current is limited by limiting the slew rate at V_{OUT} . The slew rate is controlled by a small capacitor at the dv/dt pin. The dv/dt pin has an internal circuit that allows the customer to float this pin (no connect) and still receive a 1.4ms ramp time at V_{OUT} .

The max load at the output (V_{OUT}) is current limited. This is accomplished by utilizing a sense FET topology. The magnitude of the current limit is controlled by an external resistor connected between the I_{LIMIT} pins.

An internal charge pump drives the gate of the power device, allowing a very low on-resistance DMOS power FET of just 44m Ω .

V_{OUT} is protected from V_{IN} being too low or too high. Under Voltage Lockout (UVLO) assures that the input is above the minimum operating threshold, before the power device is turned on. If V_{IN} goes above the high output threshold, the output voltage will be limited.

FEATURES

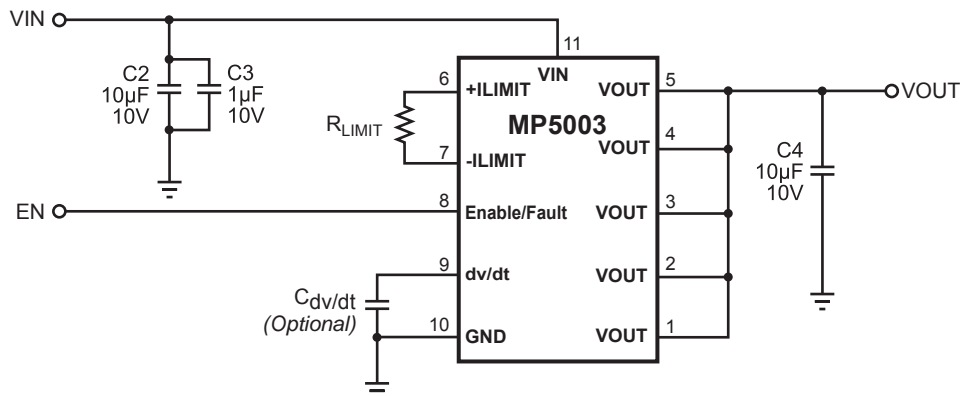
- Integrated 44m Ω Power FET
- Enable/Fault Pin
- Adjustable Slew Rate for Output Voltage
- Adjustable Current Limit: 1A-3A
- Automatically Startup after Thermal Protection
- Over Voltage Limit

APPLICATIONS

- Hot Swap
- PC Cards
- Cell Phones
- Laptops

"MPS" and "The Future of Analog IC Technology" are Registered Trademarks of Monolithic Power Systems, Inc.

TYPICAL APPLICATION

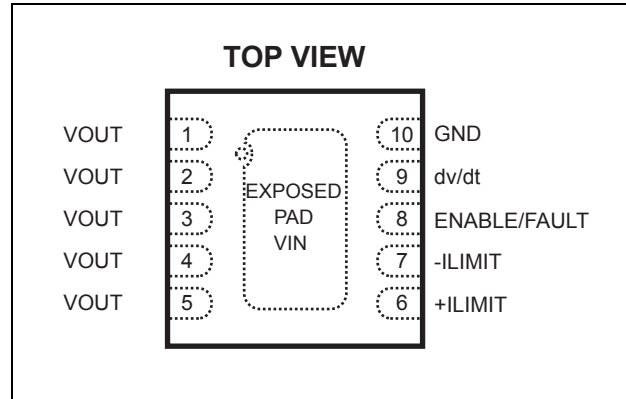


ORDERING INFORMATION

Part Number*	Package	Top Marking	Free Air Temperature (T _A)
MP5003EQ	QFN10 (3x3)	5003EQ	-20°C to +85°C

* For Tape & Reel, add suffix –Z (e.g. MP5003EQ–Z);
 For RoHS Compliant Packaging, add suffix –LF (e.g. MP5003EQ–LF–Z)

PACKAGE REFERENCE



ABSOLUTE MAXIMUM RATINGS ⁽¹⁾

V_{IN}, V_{OUT}, +I_{LIMIT}, -I_{LIMIT} 22V
 dv/dt, ENABLE/FAULT 6V
 Continuous Power Dissipation (T_A=+25°C) ⁽²⁾
 2.5W
 Storage Temperature..... –65°C to +155°C
 Junction Temperature.....-20°C to +150°C

Recommended Operating Conditions

Input Voltage Operating Range.....2.5V to 6V
 Operating Junct.Temp(T_J).....–20°C to +125°C

Thermal Resistance ⁽³⁾ **θ_{JA}** **θ_{JC}**
 QFN1050 12 ... °C/W

Notes:

- Exceeding these ratings may damage the device..
- The maximum allowable power dissipation is a function of the maximum junction temperature T_J(MAX), the junction-to-ambient thermal resistance θ_{JA}, and the ambient temperature T_A, the maximum allowable power dissipation at any ambient temperature is calculated using: P_D(MAX)=(T_J(MAX)-T_A)/ θ_{JA}. Exceeding the maximum allowable power dissipation will cause excessive die temperature, and the regulator will go into thermal shutdown. Internal thermal shutdown circuitry protects the device from permanent damage. Reduce 0.2 Watts for every 10°C ambient temperature increasing
- Measured on JESD51-7 4-layer board.

ELECTRICAL CHARACTERISTICS

$V_{IN} = 3.3V$, $R_{LIMIT}=24\Omega$, $C_{OUT}= 10\mu F$, $T_J=25^\circ C$, unless otherwise noted.

Parameters	Symbol	Condition	Min	Typ	Max	Units
Power FET						
Delay Time	t_{DLY}	Enabling of chip to $I_D=100mA$ with a 12Ω resistive load		0.2		ms
ON Resistance	R_{DSon}	$T_J=+25^\circ C$		44	82	m Ω
		$T_J=+80^\circ C$, Note 4		95		
Off State Output Voltage	V_{OFF}	Enable=0V, $R_L=500\Omega$			120	mV
Thermal Latch						
Shutdown Temperature	T_{SD}	Note 4		175		$^\circ C$
Under/Over Voltage Protection						
Output Clamping Voltage	V_{CLAMP}	Overvoltage Protection $V_{IN} = 6V$	3.63	4.03	4.43	V
Under Voltage Lockout	V_{UVLO}	Turn on, Voltage going high	2.15	2.35	2.5	V
Under Voltage Lockout (UVLO) Hysteresis	V_{HYST}			100		mV
Current Limit						
Short Circuit Current Limit (Hold Current)	I_{LIM}	$R_{LIMIT}=24\Omega$, Note 4	1.2	1.55	1.9	A
Trip Current	I_{LIM-OL}	$R_{LIMIT}=24\Omega$, Note 4		2.5		A
dv/dt Circuit						
Slew Rate	dv/dt	Enable to $V_{OUT}=3.0V$, Note 5	0.8	1.4	2.5	ms
Enable/Fault						
Low Level Input Voltage	V_{IL}	Output Disabled			0.5	V
High Level Input Voltage	V_{IH}	Output Enabled	2.5			V
High State Maximum Voltage	$V_{I(MAX)}$			3.25		V
Low Level Input Current (Sink)	I_{IL}	$V_{ENABLE}=0V$		-55	-75	μA
Maximum Fanout for Fault Signal		Total number of chips that can be connected for simultaneous shutdown			5	Units
Maximum Voltage on Enable Pin	V_{MAX}	Note 6			V_{IN}	V
Total Device						
Bias Current	I_{BIAS}	Device Operational		1.5	2.0	mA
		Thermal Shutdown		0.9		
Minimum Operating Voltage for UVLO	V_{MIN}	Enable<0.5V			2.0	V

Notes:

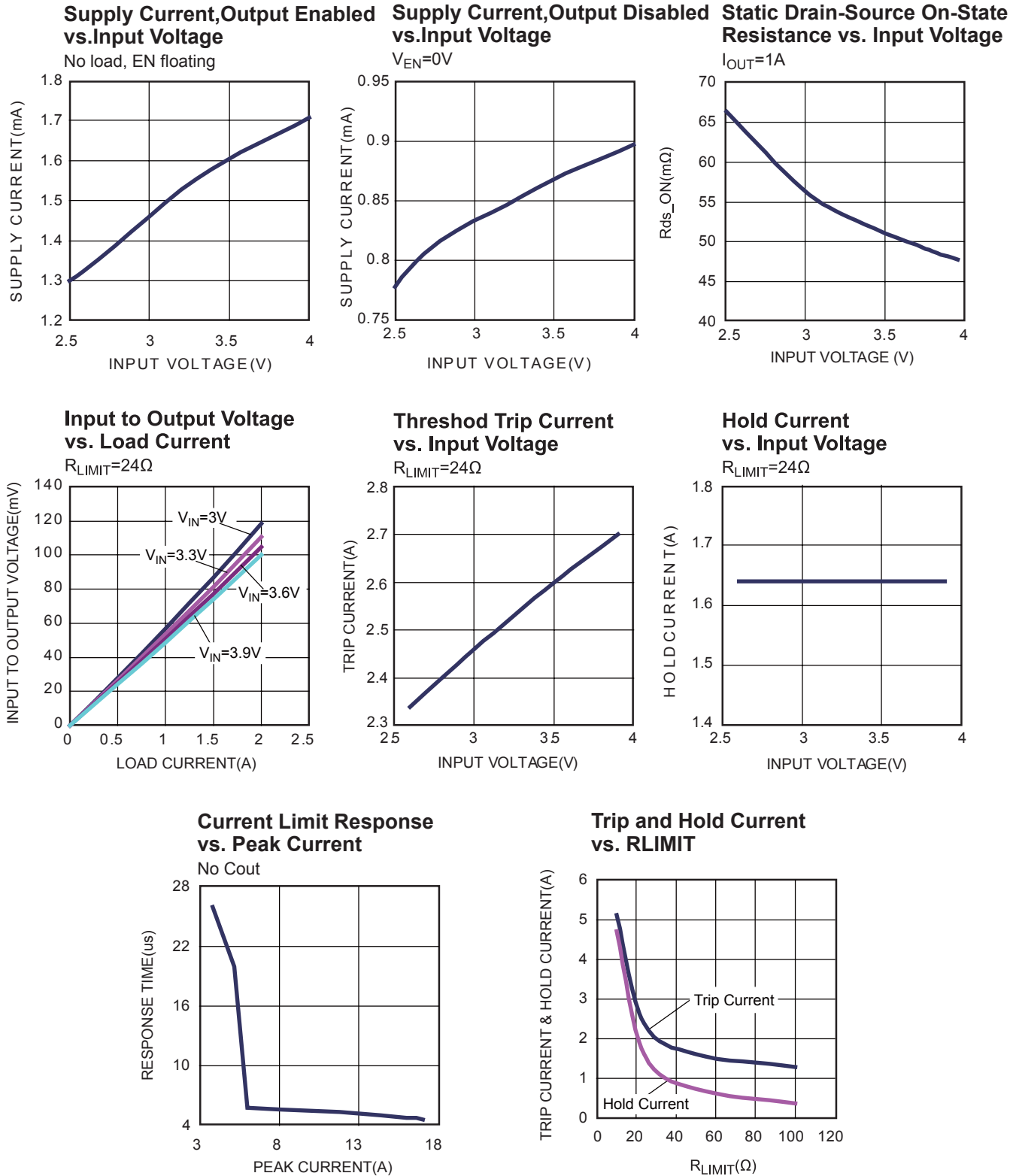
- 4) Guaranteed by design.
- 5) Measure at (30% to 90%)/0.6.
- 6) Maximum Input Voltage to be $\leq 4.43V$ if $V_{IN} \geq 4.43V$. Maximum Input Voltage to be V_{IN} if $V_{IN} \leq 4.43V$.

PIN FUNCTIONS

Pin #	Name	Description
1-5	VOUT	This pin is the V_{OUT} of the internal power FET and the output terminal of the IC.
6	+ILIMIT	A resistor between these pins sets the overload and short circuit current limit levels.
7	-ILIMIT	A resistor between these pins sets the overload and short circuit current limit levels.
8	Enable/Fault	The Enable/Fault pin is a bi-directional interface. It can be used to enable the output of the device by floating the pin, or disable the chip by pulling it to ground (using an open drain or open collector device). If a thermal fault occurs, the voltage on this pin will drive to ground, automatically.
9	dv/dt	The internal dv/dt circuit controls the slew rate of the output voltage at turn on. It has an internal capacitor that allows it to ramp up over the period of 1.5ms. An external capacitor can be added to this pin to increase the ramp time. If an additional time delay is not required, this pin should be left open.
10	GND	Negative Input Voltage to the Device. This is used as the internal reference for the IC.
11	VIN	Positive input voltage to the device (Exposed Pad).

TYPICAL PERFORMANCE CHARACTERISTICS

$V_{IN}=3.3V$, $V_{EN}=3.3V$, $R_{LIMIT}=24\Omega$, $C_{OUT}=10\mu F$, $C_{dv}/dt=1nF$, $T_A=25^\circ C$, unless otherwise noted.

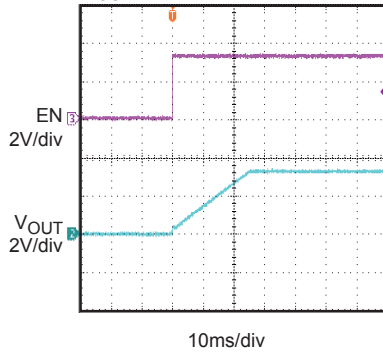


TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_{IN}=3.3V$, $V_{EN}=3.3V$, $R_{LIMIT}=24\Omega$, $C_{OUT}=10\mu F$, $C_{dv/dt}=1nF$, $T_A=25^\circ C$, unless otherwise noted.

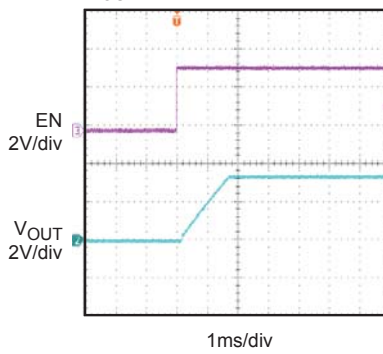
**Turn on Delay and Rise Time
Cdv/dt=1nF**

$C_{OUT}=10\mu F$, no load



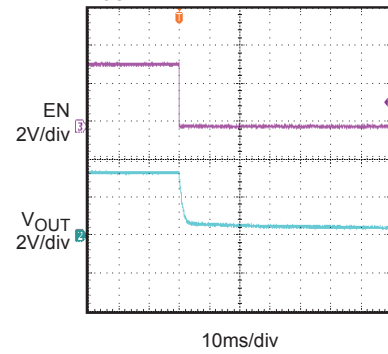
**Turn on Delay and Rise Time
No Cdv/dt**

$C_{OUT}=10\mu F$, no load



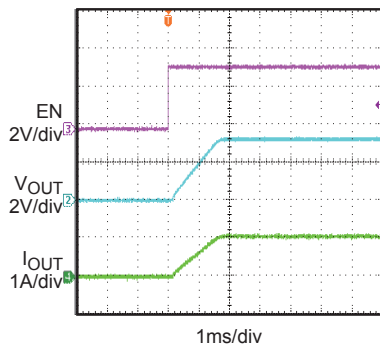
**Turn off Delay and Fall Time
No Cdv/dt**

$C_{OUT}=10\mu F$, no load



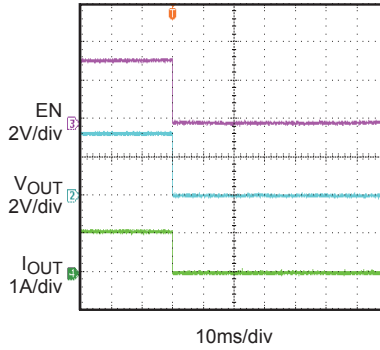
**Turn on Delay and Rise Time
No Cdv/dt**

$C_{OUT}=10\mu F$, $R_{LOAD}=3.3\Omega$



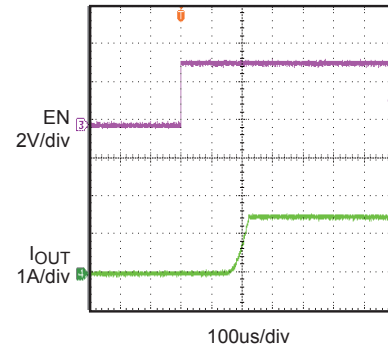
**Turn off Delay and Fall Time
No Cdv/dt**

$C_{OUT}=10\mu F$, $R_{LOAD}=3.3\Omega$



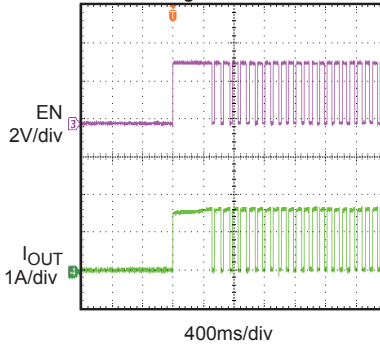
**Short Circuit Current,
Device Enabled into Short**

No Cdv/dt



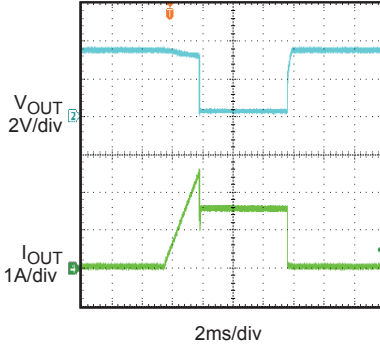
**Short Circuit Current,
Device Enabled into Short,
Thermal Shut down, and
Auto Start Up**

EN Floating, No Cdv/dt



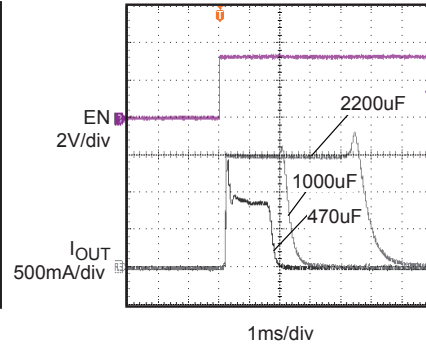
**Trip Current with Ramped
Load on Enabled Device**

No Cdv/dt



**Inrush Current with Different
Load Capacitance**

No Cdv/dt

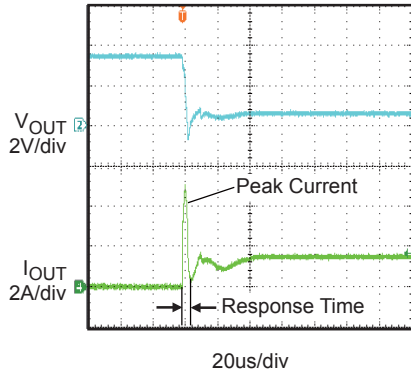


TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$V_{IN}=3.3V$, $V_{EN}=3.3V$, $R_{LIMIT}=24\Omega$, $C_{OUT}=10\mu F$, $C_{dv}/dt=1nF$, $T_A=25^\circ C$, unless otherwise noted.

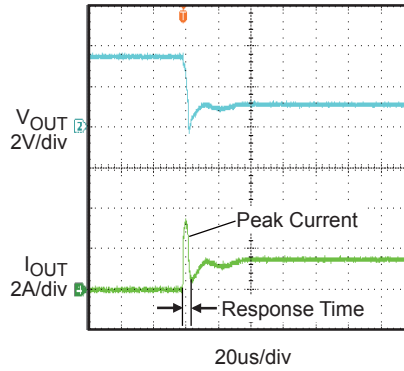
0.33Ω Load Connected to Enabled Device

No Cdv/dt, No C_{OUT}



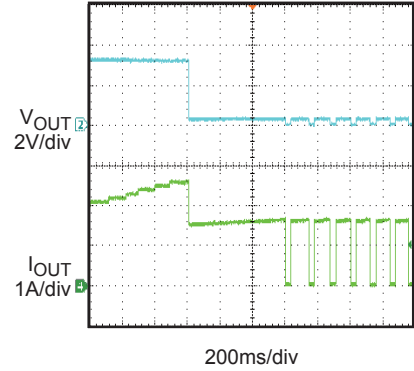
0.66Ω Load Connected to Enabled Device

No Cdv/dt, No C_{OUT}



Current Limit (trip → hold → thermal shut down → Auto Start Up)

No Cdv/dt



BLOCK DIAGRAM

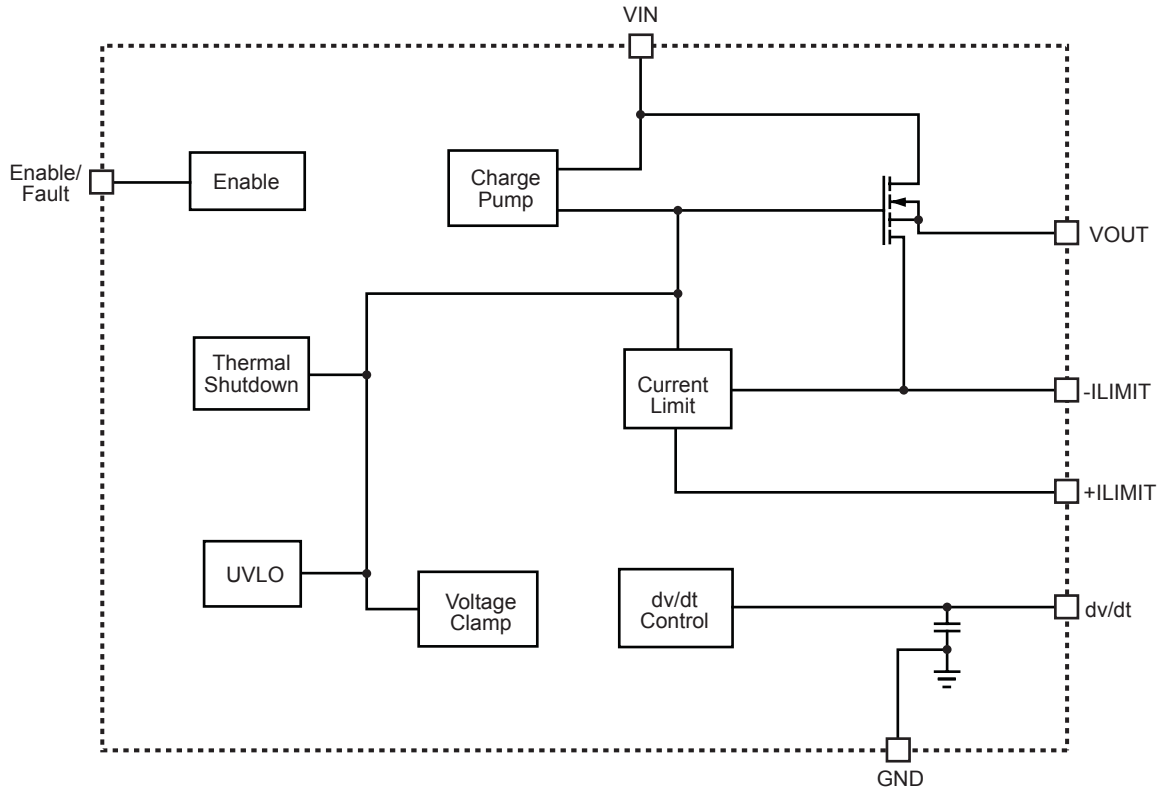


Figure 1—Functional Block Diagram

CURRENT LIMIT

The desired current limit is a function of the external current limit resistor.

Table 1—Current Limit vs. Current Limit Resistor (V_{IN}=3.3V)

Current Limit Resistor (Ω)	13	24	50	100
Trip Current (A)	4	2.5	1.7	1.37
Hold Current (A)	3.2	1.55	0.77	0.37

The hold current refers to the current limit. However, the current limit is set to the “trip current” level when the output is near V_{IN}. As the output decreases, the current limit is decreased to the “hold current” level. The rated output current should be less than or equal to the hold current.

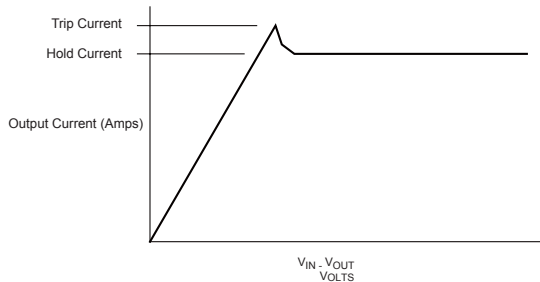


Figure 2—Load Current vs. Voltage Drop

In a typical application using a current limit resistor of 24Ω, the trip current will be 2.5A and the hold current will be 1.55A. If the device is in its normal operating state and passing 1.5A it will need to dissipate only 99mW with the very low on resistance of 44mΩ. For the package dissipation of 50°C/Watt, the temperature rise will only be +5°C. Combined with a 25°C ambient, this is only 30°C total package temperature.

During a short circuit condition, the device now has 3.3V across it and the hold current clamps at 1.55A and therefore must dissipate 5W. At 50°C/watt, if uncontrolled, the temperature would rise above the thermal protection threshold (+175°C) and the device will shutdown to cause the temperature to drop.

Proper heat sink must be used if the device is intended to supply the hold current and not shutdown. Without a heat sink, hold current

should be maintained below 909mA at + 25°C and below 545mA at +85°C to prevent the device from activating the thermal shutdown feature.

RISE TIME

The rise time is a function of the capacitor (C_{dv/dt}) on the dv/dt pin.

Table 2—Rise Time vs. C_{dv/dt}

C _{dv/dt}	none	50pF	500pF	1nF
Rise Time (TYPICAL) (ms)	1.4	2.8	15.4	29.4

* Notes: Rise Time = K_{RT}*(50pF+C_{dv/dt}), K_{RT} =28E6

The “start-up rise time” is measured by taking the 10% to 90% time and multiplied by 1.25 to get the “interpolated” 0% to 100% rise time.

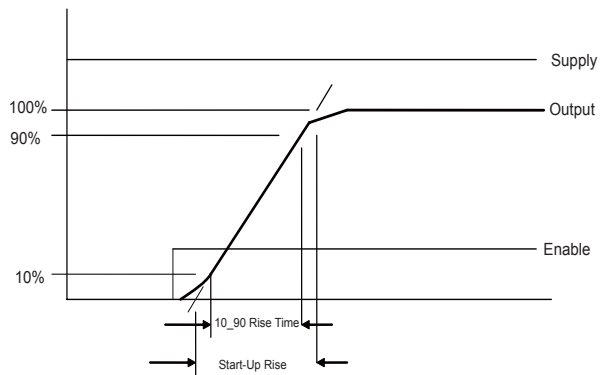


Figure 3—Start-up Rise Time

FAULT AND ENABLE PIN

The Enable/Fault Pin is a Bi-Directional I/O with a weak pull up current (25uA typical). It functions to enable/disable the part.

Enable pin as an input:

1. Low disables the part.
2. High enables the part.

Enable pin as an output:

1. The pull up current may (if not overridden) allow a “wired nor” pull up to enable the part.
2. An under voltage will cause a low on the enable pin.
3. A thermal fault will cause a low level on the enable pin.

There are 4 types of faults, and each fault has a direct and indirect effect on the Enable/Fault pin and the internal fault flag. In a typical application where there are multiple MP5003 chips in a system, the enable/fault lines are typically connected together.

When the supply goes above the UVLO threshold, the output is enabled and the Enable/fault pin is released. When the Enable/fault pin is released it will be pulled high by a 25uA current source. No external pull up resistor is required. In addition, the pull up voltage is limited to 5 volts.

UNDER VOLTAGE LOCK OUT OPERATION

If the supply (input) is below the UVLO threshold, the output is disabled, and the fault line is driven low.

Table 3—Fault Function Influence in Application

Fault description	Internal action	Effect on Fault Pin	Effect on Flag	Effect on secondary Part
Short/over current	Limit current	none	none	none
Under Voltage	Output is turned off	Internally drives Enable/Fault pin to Logic low	Flag is reset	Secondary part output is disabled, and fault flag is reset.
Over Voltage	Limit output voltage	None	None	None
Thermal Shutdown	Shutdown part. The part retries to start up automatically	Internally drives Enable/Fault pin to low level, and after part cools down, Enable/Fault pin will be pulled high	Flag is Set at thermal shut down, and is set to high after auto start up.	Secondary part output is disabled when thermal shut down, and is enabled after MP5003 auto start up.

THERMAL PROTECTION

The MP5003 only considers a thermal overload to be a fault. Under a fault condition the MP5003 will have two actions:

- 1) Turn off the output power device.
- 2) Drive the enable/fault pin to the low level.

The power device will remain off until the die temperature drops below the hysteresis level.

When the die cools down below the thermal hysteresis level, the MP5003 will restart in the start up mode and the fault line will be pulled high through a 25uA pull up current. If the cause of

the fault has been removed, the output will ramp up in a controlled fashion with the ramp rate controlled by the dv/dt function. If the cause of the fault is still present, the excess power dissipation will heat up the part. When the die temperature reaches the thermal shutdown temperature, the output will be turned off and the enable/fault pin will be driven to the low level. This cycle will repeat until the cause of the fault is removed.

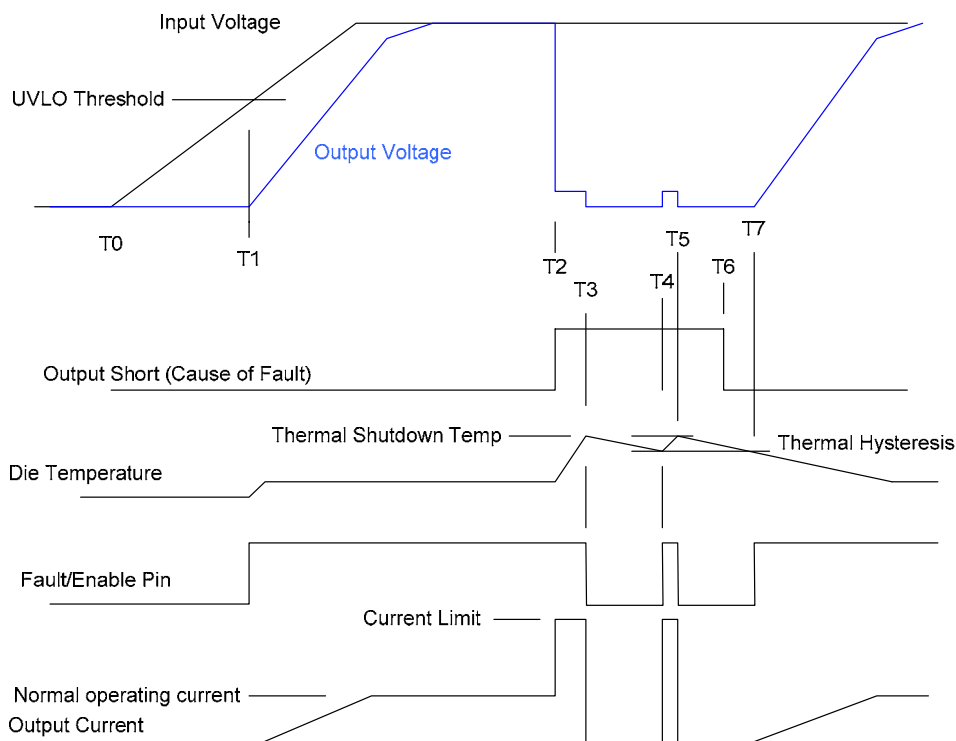


Figure 4—Thermal Protection in Short Condition

The drawing above shows the initial start up sequence and the occurrence of a short at the output.

At time T0 the input voltage begins to rise. At T1 the input voltage rises above the UVLO threshold and the part starts up. The output current ramps up and settles in at the normal operating current level until time T2. There is a very small temperature heating of the die in normal operation.

At time T2 the output is shorted. This brings the output very close to ground. The output current increases to the current limit level and is held there by the MP5003. Because of the large current and the large voltage across the power device, the die will begin to heat up.

At time T3 the die temperature is at the thermal shutdown level and the part will turn the power device off. The enable/fault pin is driven to the low level. Once the power device is off, the die temperature will begin to drop.

At time T4 the part has cooled down below the thermal hysteresis level. The enable pin goes high and the part turns on again. But the short is still present, causing the die temperature to increase. At time T5 the power device turns off and the Enable/Fault pin is driven to the low level, again. The temperature begins to fall.

The cycle between times T3, T4 and T5 could repeat indefinitely, but at time T6 the short is removed. At time T7 the die temperature is below the thermal hysteresis level and the part turns on once again. This time there is no short, so the output starts in normal operation and the die temperature cools down to the normal operating range.

PCB LAYOUT

PCB layout is very important to achieve stable operation. Please follow these guidelines and take below figure for reference.

Place R_{limit} close to I_{limit} pin, C_{dv/dt} close to dv/dt pin and input cap close to VIN (Exposed Pad). Keep the N/C pin float. Put vias in thermal pad and ensure enough copper area near VIN and VOUT to achieve better thermal performance.

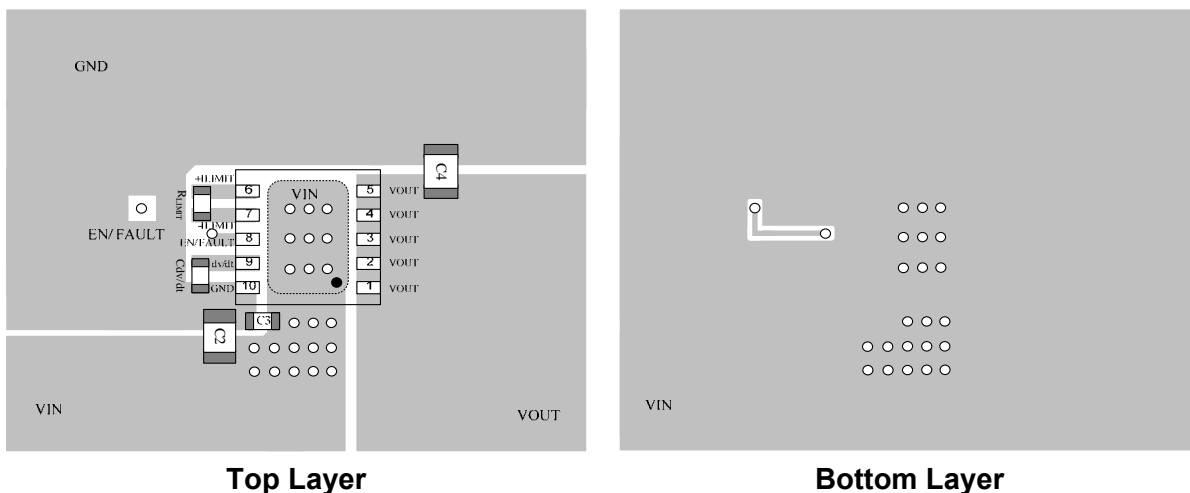
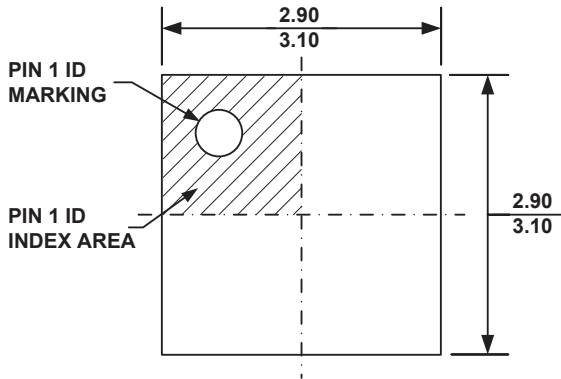


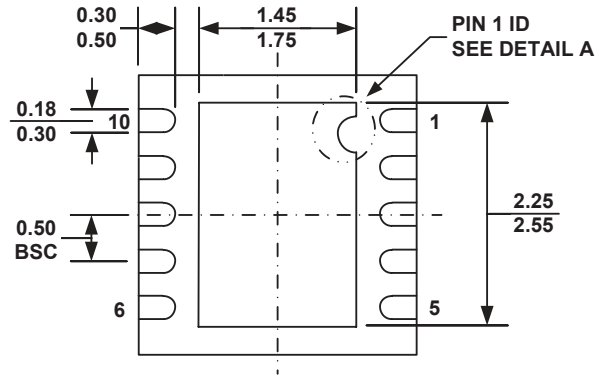
Figure 5—PCB Layout

PACKAGE INFORMATION

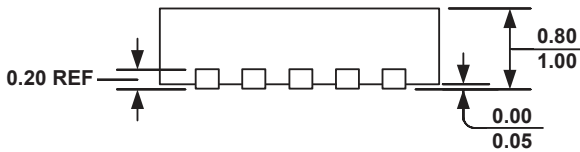
QFN10 (3mm x 3mm)



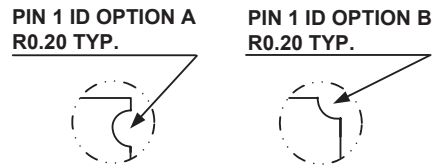
TOP VIEW



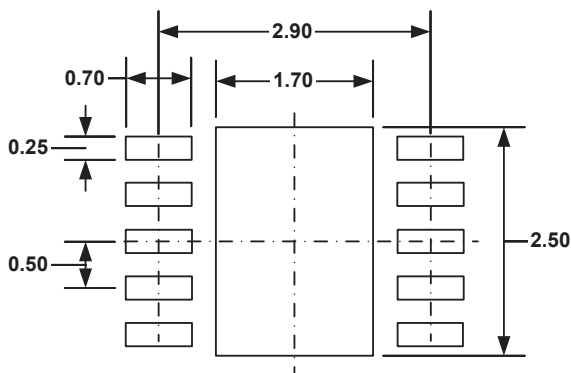
BOTTOM VIEW



SIDE VIEW



DETAIL A



RECOMMENDED LAND PATTERN

NOTE:

- 1) ALL DIMENSIONS ARE IN MILLIMETERS.
- 2) EXPOSED PADDLE SIZE DOES NOT INCLUDE MOLD FLASH.
- 3) LEAD COPLANARITY SHALL BE 0.10 MILLIMETER MAX.
- 4) DRAWING CONFORMS TO JEDEC MO-229, VARIATION VEED-5.
- 5) DRAWING IS NOT TO SCALE.

NOTICE: The information in this document is subject to change without notice. Users should warrant and guarantee that third party Intellectual Property rights are not infringed upon when integrating MPS products into any application. MPS will not assume any legal responsibility for any said applications.